`	 n Note	_

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/851,467	FUNG ET AL.	
Examiner	Art Unit	
Le Nguyen	2174	

SEARCHED			
Class	Subclass	Date	Examiner
715	779	10/28/2005	LVN
			·
<u></u> .			
			-

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
	-		-
	GPUB: ,779,739	10/28/2005	LVN

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
US-PGPUB; USPAT: 715/808,779,739; 725/38-61	10/28/2005	LVN
· · · · · · · · · · · · · · · · · · ·		